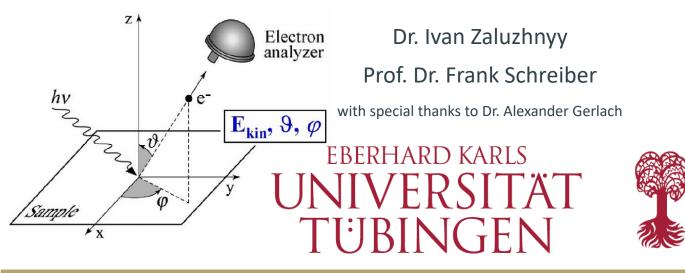
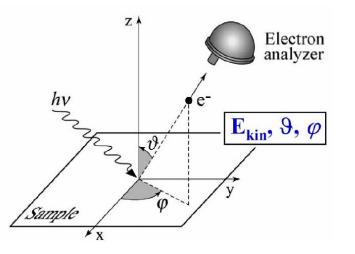


Advanced Topics in Condensed Matter

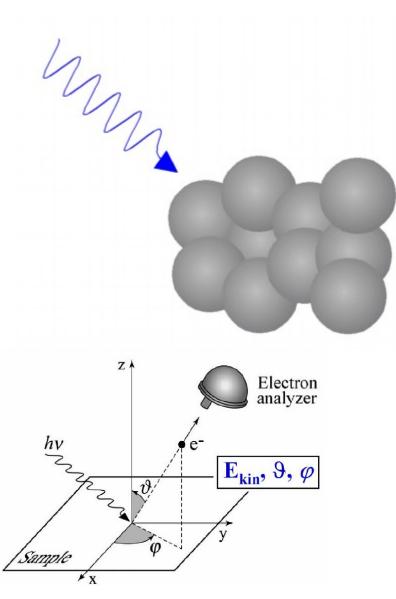
Lecture 9: Electronic Structure probed with Photoelectrons



Photoelectrons



Photoelectrons



 $M + hv \rightarrow M^+ + e^-$

- Photoelectron spectroscopy (PES; in general)
- X-ray photoelectron spectroscopy (XPS) hv = 50 ... 5000 eV
- Ultraviolet photoelectron spectroscopy (UPS) hv = 10 ... 50 eV

Photoelectrons: History

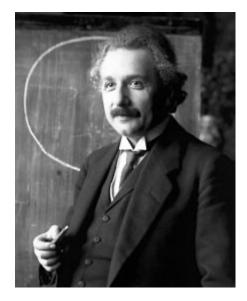
6. Über einen die Erzeugung und Verwandlung des Lichtes betreffenden heuristischen Gesichtspunkt; von A. Einstein.

Zwischen den theoretischen Vorstellungen, welche sich die Physiker über die Gase und andere ponderable Körper gebildet haben, und der Maxwellschen Theorie der elektromagnetischen Prozesse im sogenannten leeren Raume besteht ein tiefgreifender formaler Unterschied. Während wir uns nämlich den Zustand eines Körpers durch die Lagen und Geschwindigkeiten einer zwar sehr großen, jedoch endlichen An-

Raume verteilt sei. Nach der hier ins Auge zu fassenden Annahme ist bei Ausbreitung eines von einem Punkte ausgehenden Lichtstrahles die Energie nicht kontinuierlich auf größer und größer werdende Räume verteilt, sondern es besteht dieselbe aus einer endlichen Zahl von in Raumpunkten lokalisierten Energiequanten, welche sich bewegen, ohne sich zu teilen und nur als Ganze absorbiert und erzeugt werden können.

... demonstrates the particle nature of light

1. H. Hertz, Ann. Physik 31, 983 (1887). 2. A. Einstein, Ann. Physik 17, 132 (1905).



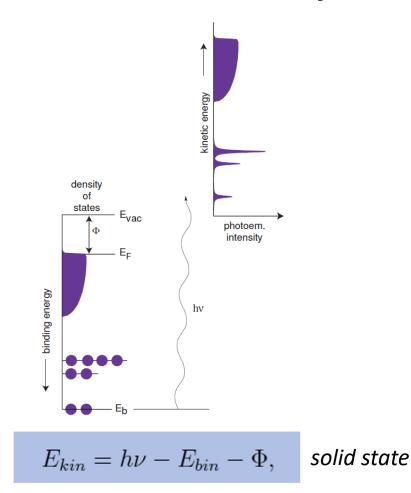
$$E_{kin}^{\max} = h \nu - \Phi$$

1905 Albert Einstein explains photoelectric effect ^{1,2}

1921 Nobel prize

"for his services to Theoretical Physics, and especially for his discovery of the law of the photoelectric effect"

Photoelectrons: History



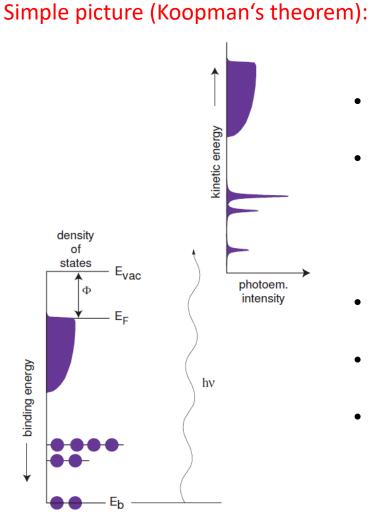


Mid1960s Kai Siegbahn and his group develop photoelectron spectroscopy¹

1981 Nobel prize "for his contribution to the development of high-resolution electron spectroscopy"

Note also Manne Siegbahn (Kai's father) 1924 Nobel prize "for his discoveries and research in the field of X-ray spectroscopy"

XPS Basics: Overview



$$E_{kin} = h\nu - E_{bin} - \Phi,$$

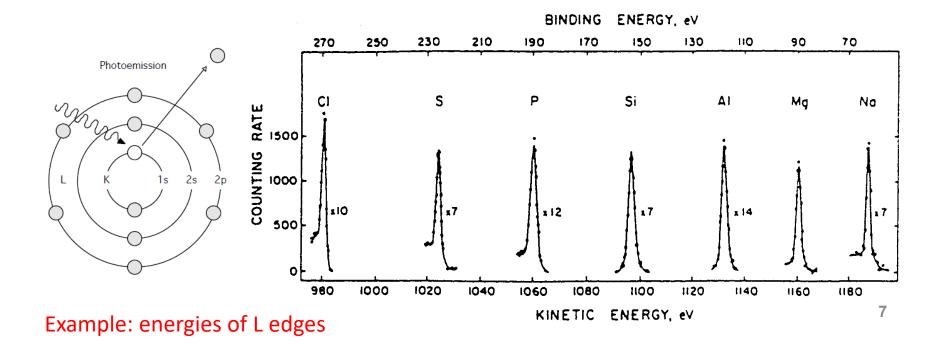
- absorption very fast ~10⁻¹⁶ s
- energy conservation (with workfunction φ)
 - no photoemission for $hv < \phi$
 - no photoemission from levels with $E_{bin} + \phi > hv$
 - E_{kin} of photoelectron increases as E_{bin} decreases
- intensity of photoemission ~ intensity of photons
- monochromatic (x-ray) incident beam needed
- since each element has unique set of core levels,
 E_{kin} 's can be used to fingerprint element

$$I(E_{kin}) = DOS(h\nu - E_{kin} - \Phi)$$

XPS Basics: Element-Specific Energies



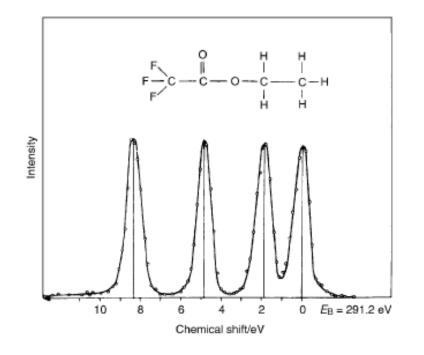
- E_{bin} follows energy of levels $E_{bin} (1s) > E_{bin} (2s) > E_{bin} (2p) > E_{bin} (3s)$
- E_{bin} of orbitals increases with Z E_{bin} (Na 2s) < E_{bin} (Mg 2s) < E_{bin} (Al 2s)



XPS Basics: Chemical Shifts of Core Levels

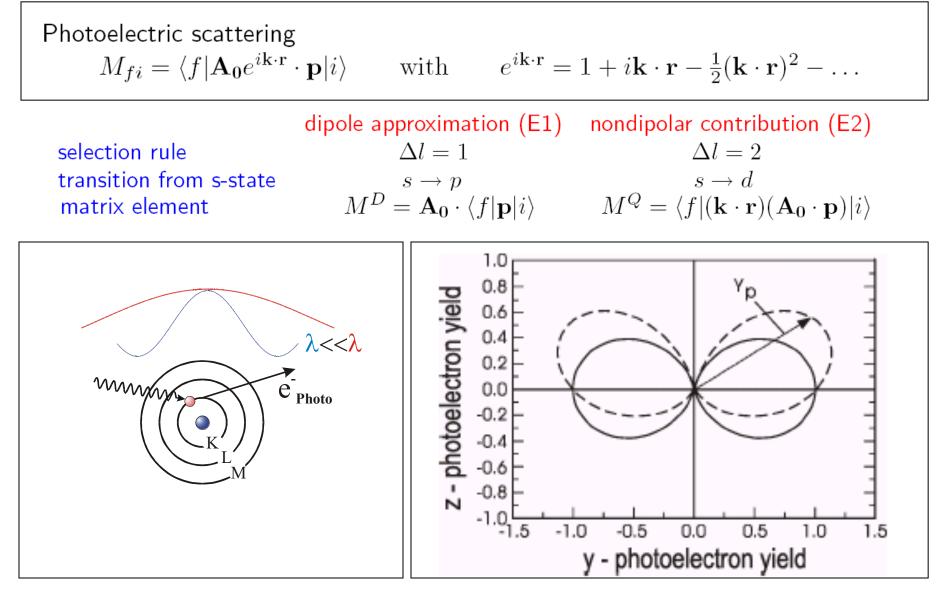
Information about chemical environment of the atoms (here C(1s) levels)

- Core level chemical shifts caused by overall charge redistribution depending on the bonding partners (*initial state effect*)
- Charge withdrawal increases BE by reducing nuclear shielding



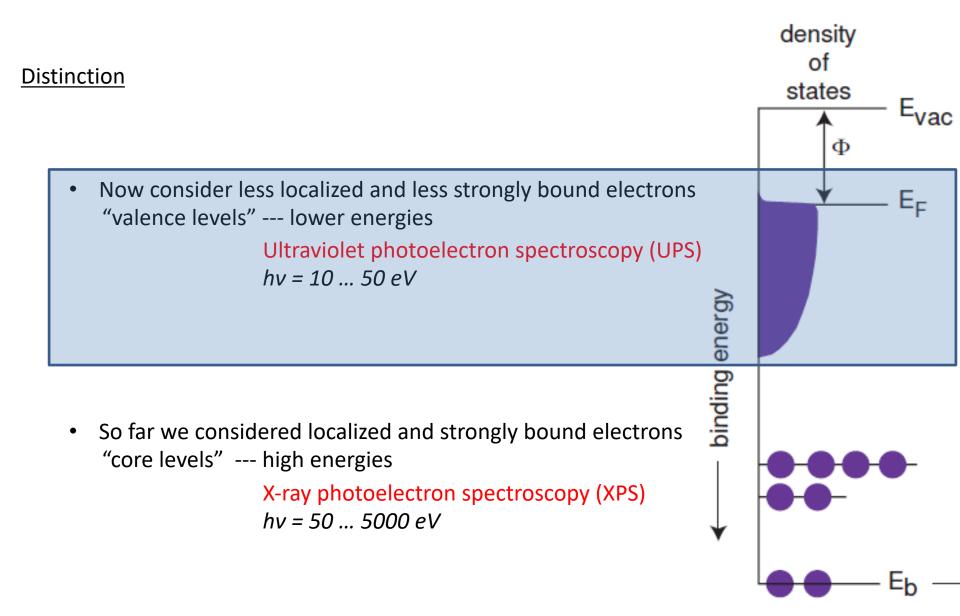
Functional Group		Binding Energy (eV)
hydrocarbon	<u>С</u> -Н, <u>С</u> -С	285.0
amine	<u>C</u> -N	286.0
alcohol, ether	<u>С</u> -О-Н, <u>С</u> -О-С	286.5
CI bound to C	<u>C</u> -CI	286.5
F bound to C	<u>C</u> -F	287.8
carbonyl	<u>C</u> =O	288.0

Photoelectrons: Matrix Element for Transitions



Vartanyants and Zegenhagen phys stat sol b 215 (1999) 819 Schreiber et al., Surf. Sci. Lett. 486 (2001) L519

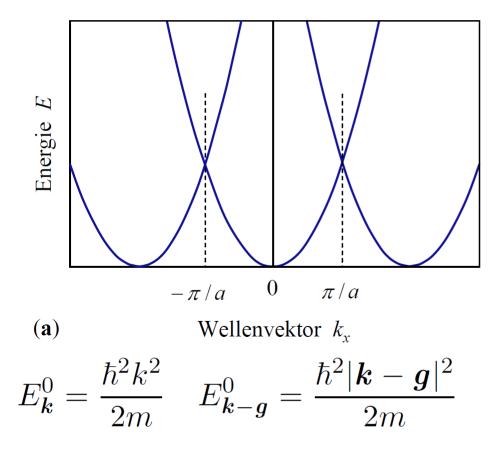
Photoelectrons



... approach from free electrons with weak (periodic) perturbation

... approach from atomic levels broadened by neighboring atoms

... approach from free electrons with weak (periodic) perturbation



... approach from free electrons with weak (periodic) perturbation

$$\widetilde{V}(r) = \sum \widetilde{V}_{G} e^{iG \cdot r}$$

$$H\psi(r) = \left[-\frac{\hbar^{2}}{2m}\Delta + \widetilde{V}(r)\right]\psi(r) = E\psi(r)$$

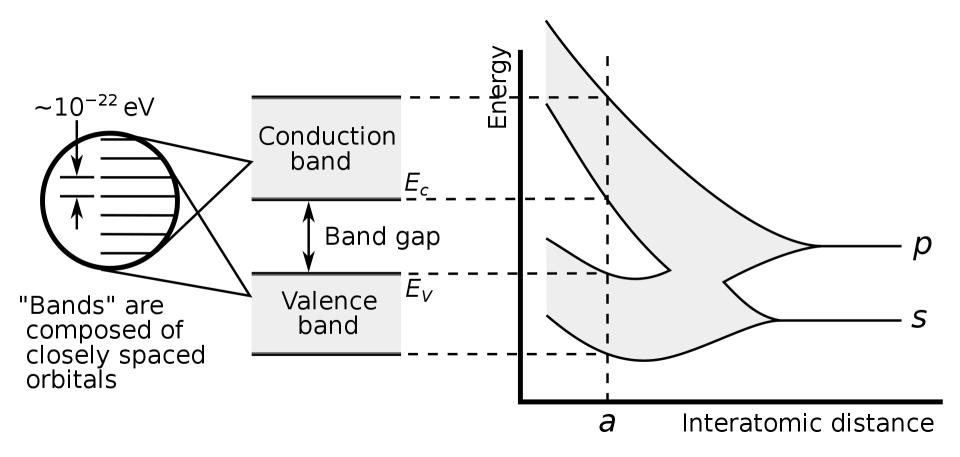
$$\lim_{\sigma \to 0^{-\pi/a}} \int_{\pi/a} \int_{\pi/a$$

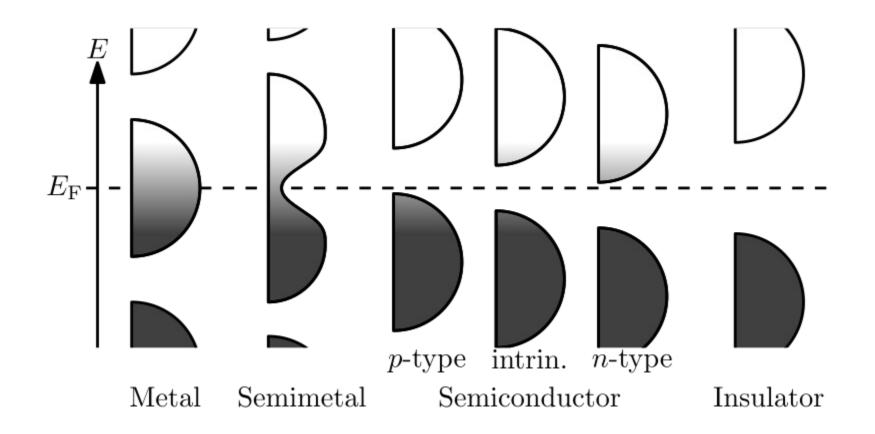
Hunklinger

... approach from free electrons with weak (periodic) perturbation

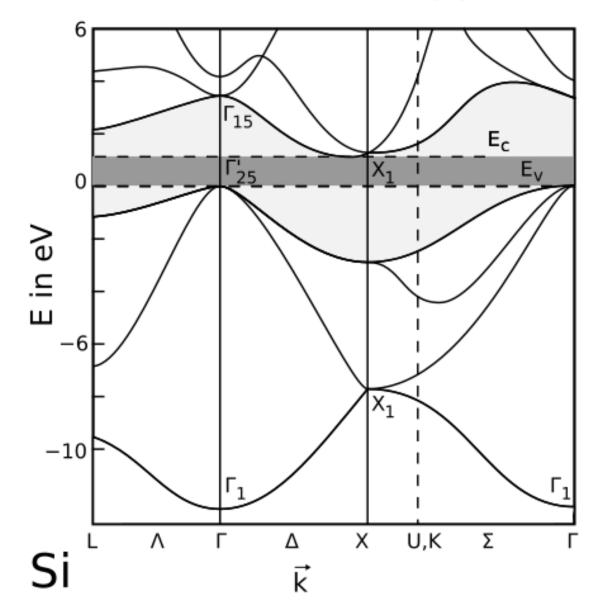
... approach from atomic levels broadened by neighboring atoms

... approach from free electrons with weak (periodic) perturbation ... approach from atomic levels broadened by neighboring atoms

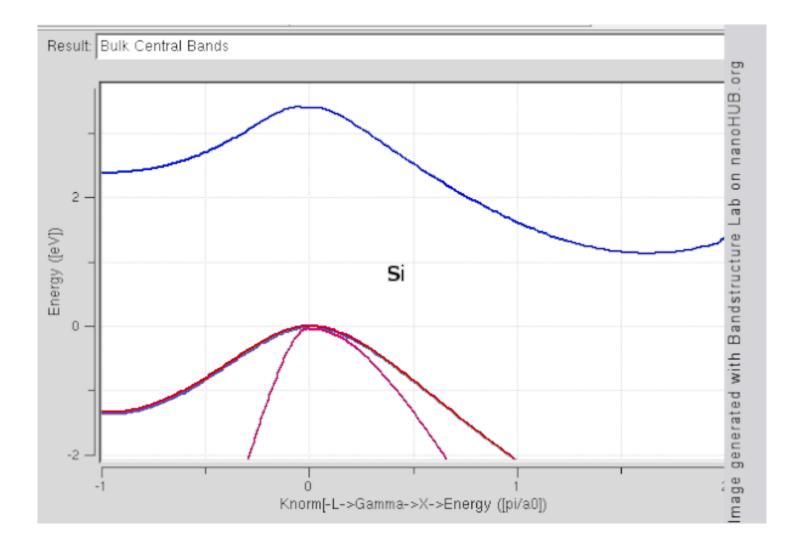




Some Real Electronic Structures E(k)



Some Real Electronic Structures E(k)



UPS Basics: Measurement of Dispersion E(k)

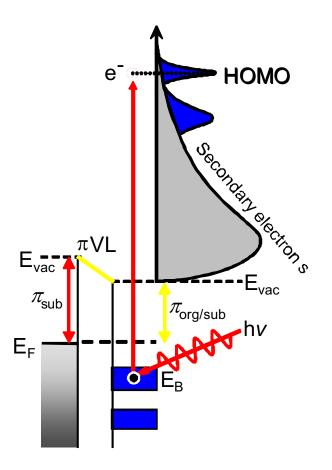
Measurement of energy dispersion E(k)

Angle-resolved photoelectron spectroscopy (ARPES)

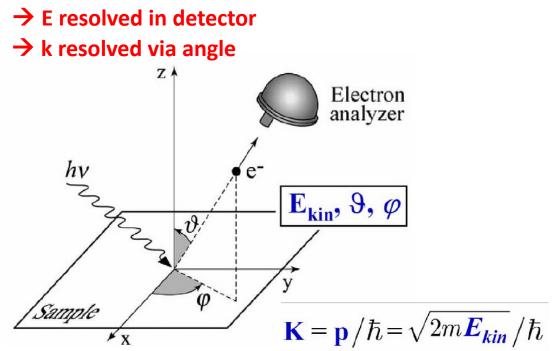
⇒ E resolved in detector ⇒ k resolved via angle hv θ E_{kin}, \vec{k}

Energy conservation

$$\boldsymbol{E}_{kin} = h\nu - \phi - |\boldsymbol{E}_{\boldsymbol{B}}|$$



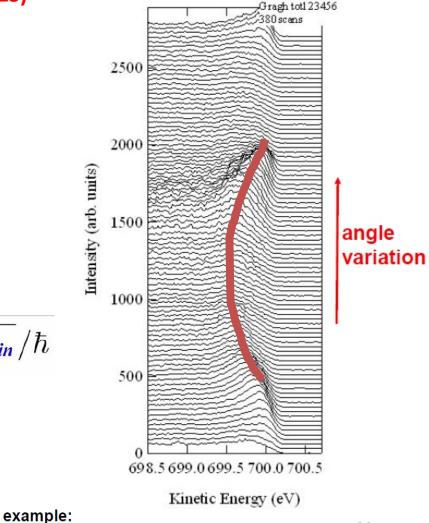
UPS Basics



Angle-resolved photoelectron spectroscopy (ARPES)

Momentum conservation

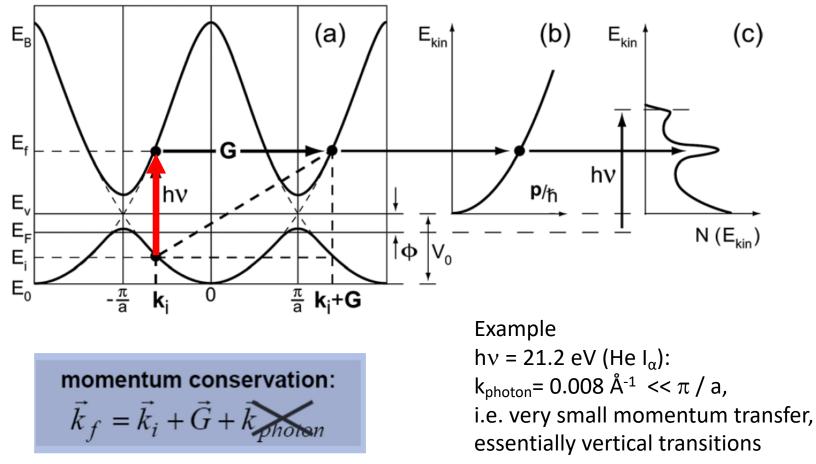
$$\hbar \mathbf{k}_{\parallel} = \hbar \mathbf{K}_{\parallel} = \sqrt{2m \boldsymbol{E}_{kin}} \cdot \sin \boldsymbol{\vartheta}$$



soft x-ray ARPES on Sr₂Ru_{1-x}Ti_xO₄

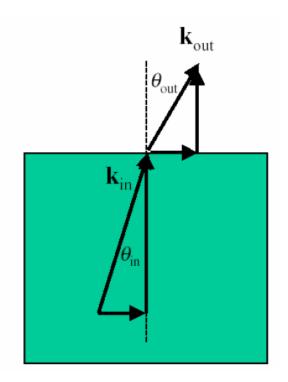
UPS Basics

Photo-excitation in a periodic potential



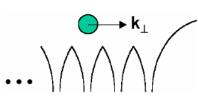
UPS Basics

3D systems (k⊥ ≠ 0)

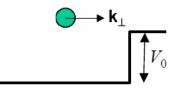


Free-electron final state model

surface potential step









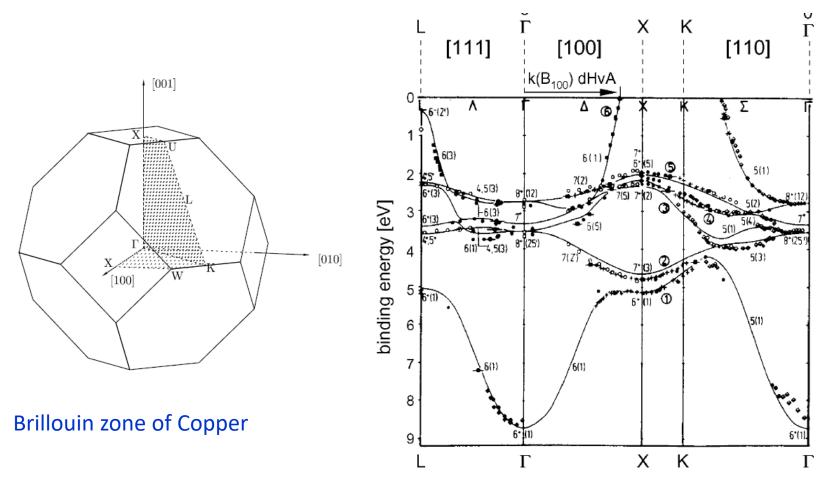
Kinematic relations

$$E_{kin} = \frac{\hbar^2 \bar{K}_{out}^2}{2m} = \frac{\hbar^2 \bar{k}_{in}^2}{2m} - V_0$$

$$\Rightarrow \begin{cases} k_{in,||} = K_{out,||} = \sqrt{\frac{2m}{\hbar^2}} E_{kin} \sin \theta_{out} \\ k_{in,\perp} = \sqrt{\frac{2m}{\hbar^2}} (E_{kin} \cos^2 \theta_{out} + V_0) \end{cases}$$

UPS: Electronic Band Structure of Copper

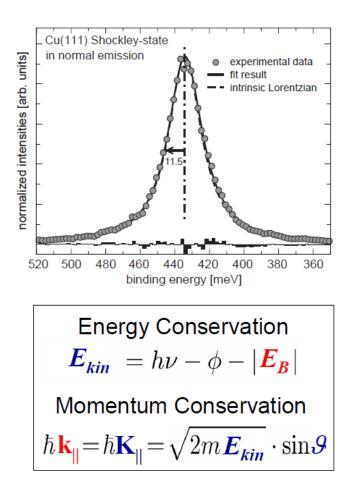
3D band mapping $(k \perp \neq 0)$:

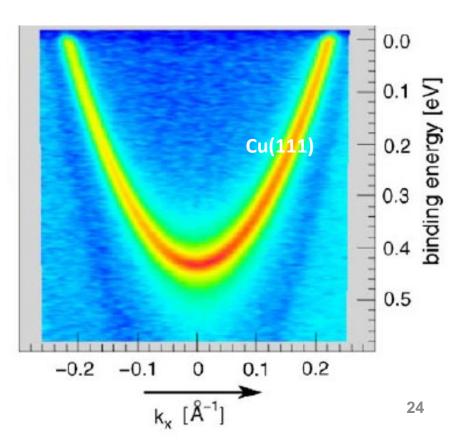


Synchrotron radiation needed

UPS: Electronic Surface States of Cu(111)

2D band mapping (k_{\perp} = 0) here with "free-electron-like" dispersion !

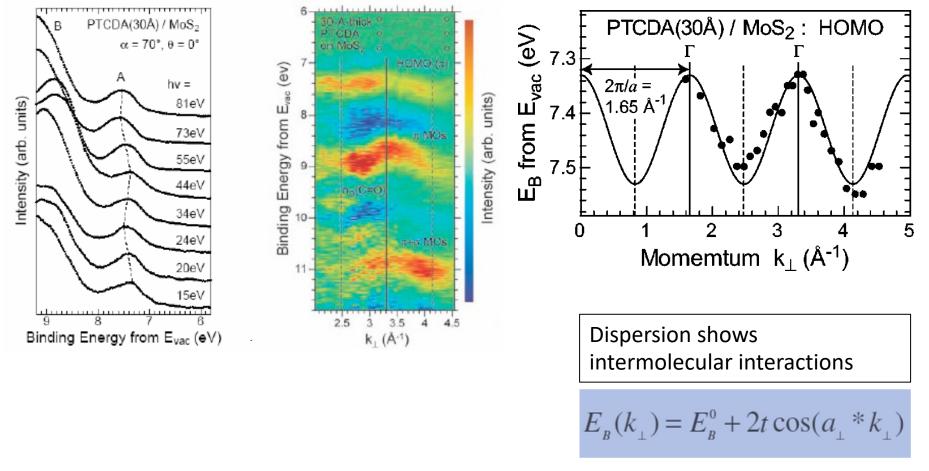




F. Reinert, Phys. Rev. B 63 (2001) 115415

UPS: Electronic Band Structure of Organic Films

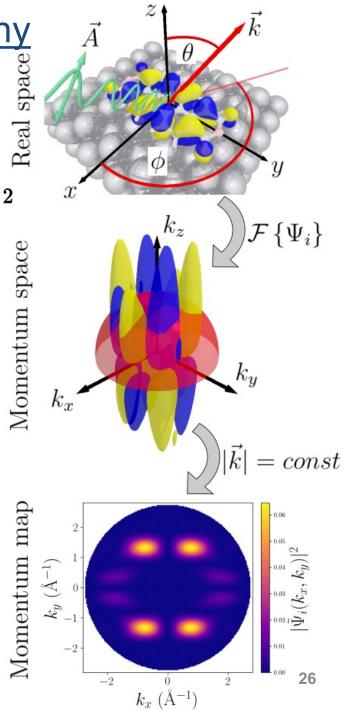
Band dispersion in organic thin films (PTCDA)



Photoelectrons: Orbital Tomography

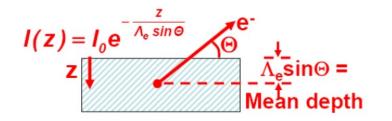
Recording emission in many directions

$$egin{aligned} I(k_x,k_y;E_{ ext{kin}}) \propto \left| \langle \Psi_f(k_x,k_y;E_{ ext{kin}}) | ec{A} \cdot ec{p} | \Psi_i
angle
ight| \ imes \delta \left(E_i + \Phi + E_{ ext{kin}} - oldsymbol{\hbar} \omega
ight) \end{aligned}$$



https://en.wikipedia.org/wiki/Photoemission_orbital_tomography

Photoelectrons: Penetration depth and HAXPES

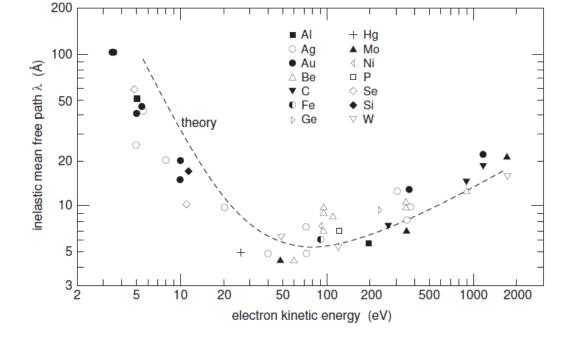


Probability of escape without loss determines Sampling depth z of XPS

If we seek information from deeper in the sample, we need high energies (hard X-ray PES, i.e. HAXPES)

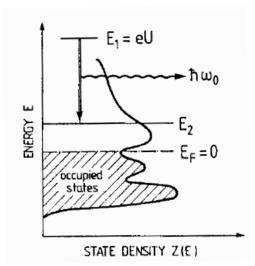
Inelastic mean free path Λ_e

- *IMFP* is the average distance between inelastic collisions
- "universal curve" of IMFP versus E_{kin}
- Maximum surface sensitivity at 50-100 eV ($\Lambda_e \sim 5$ Å)
- 95 % of electrons from $3\Lambda_e$ depth



Photoelectrons: Inverse PES

Inverse photoemission spectroscopy (IPES) probes *unoccupied* states

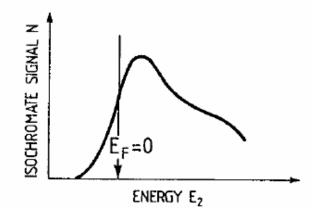


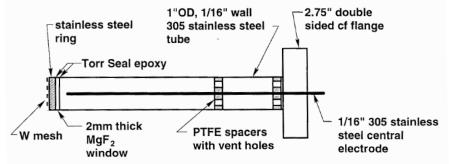
UPS

$$M + hv \rightarrow M^+ + e^-$$

IPES

$$M + e^{-} \rightarrow M^{-} + hv$$

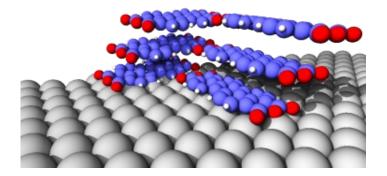


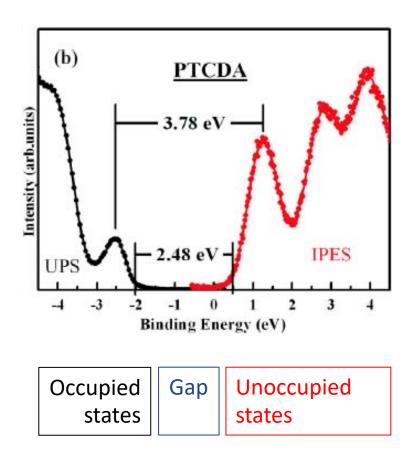


H. Lüth book

Photoelectrons: Inverse PES

PTCDA/Ag(111)

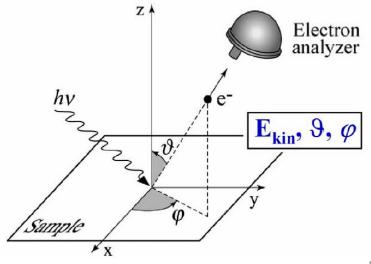




HOMO – LUMO gap 2.5 eV

Advantages of UPS

- Non-destructive
- Very surface sensitive
- Energy and momentum resolution allow band mapping for 2D and 3D systems
- Density of occupied states can be measured
- Orbital symmetry of occupied states
- Some structural information



Literature I

Some general textbooks covering PES are

- Modern Techniques of Surface Science by T. A. Delchar, and D. P. Woodruff, Cambridge Solid State Science Series, 1994
- Solid Surfaces, Interfaces and Thin Films by Hans Lüth, Springer, 2001

A general comprehensive text on photoelectron spectroscopy including XPS is

• Photoelectron Spectroscopy: Principles and Applications by S. Hüfner, Springer, 2003

An excellent collection of XPS binding energies, cross sections and a lot of other information can be found in the

• X-ray Data Booklet, that can be downloaded at xdb.lbl.gov

Example spectra as well as cross sections for XPS and APS can be found in

- Handbook of X Ray Photoelectron Spectroscopy by J. F. Moulder, et al., Physical Electronics, 1995
- Handbook of Auger Electron Spectroscopy by , L. E. Davis et al, Physical Electronics, 1978

For (angle-resolved) photoemission spectroscopy

- Photoelectron Spectroscopy: Principles and Applications by S. Hüfner, Springer, 2003.
- Solid-State Photoemission and Related Methods: Theory and Experiment by W. Schattke, M.A. Van Hove (Eds.), Wiley-VCH, Weinheim, 2003.
- Angle-resolved Photoemission by S. D. Kevan (Ed.), Elsevier, 1992.
- Photoelectron spectroscopy An overview by S. Hüfner, S. Schmidt, F. Reinert, Nuclear Instr. Meth. in Physics Research A 547 (2005) 8–23 and references therein.

More general introduction to surface science

- Concepts in Surface Physics by M. C. Desjonqueres, D. Spanjaard, Springer 2002.
- Modern Techniques of Surface Science by T. A. Delchar, and D. P. Woodruff, Cambridge Solid State Science Series, 1994.
- Solid State Physics by N. Ashcroft and N. D. Mermin, Saunders College, 1976.

Internship at ILL in Grenoble



What to remember

<u>XPS – X-ray photoelectron spectroscopy</u>

- Core levels
- Which elements are in the sample ?
- What is their (local) chemical environment ? (chemical shift)

<u>UPS – ultraviolet photoelectron spectroscopy</u>

- Valence levels
- Band structure E(k) from resolution of E and k (via angle)

Synchrotron sources

- tunable photon energy ... new opportunities
- tunable polarization